

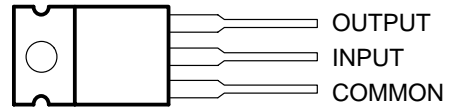
- 3-Terminal Regulators
- Output Current up to 500 mA
- No External Components
- High Power-Dissipation Capability
- Internal Short-Circuit Current Limiting
- Output Transistor Safe-Area Compensation
- Direct Replacements for Fairchild μA79M00 Series

description

This series of fixed-negative-voltage monolithic integrated-circuit voltage regulators is designed to complement the μA78M00 series in a wide range of applications. These applications include on-card regulation for elimination of noise and distribution problems associated with single-point regulation. Each of these regulators delivers up to 500 mA of output current. The internal current-limiting and thermal-shutdown features of these regulators make them essentially immune to overload. In addition to use as fixed-voltage regulators, these devices can be used with external components to obtain adjustable output voltages and currents, and also as the power-pass element in precision regulators.

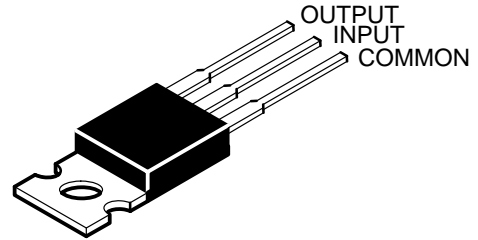
The μA79M00C series is characterized for operation over the virtual junction temperature range of 0°C to 125°C.

KC PACKAGE
(TOP VIEW)

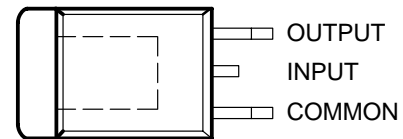


The INPUT terminal is in electrical contact with the mounting base.

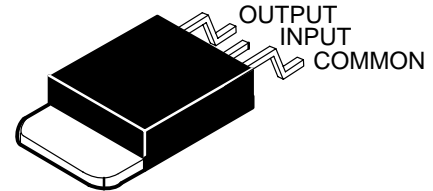
TO-220AB



KTP PACKAGE
(TOP VIEW)



The INPUT terminal is in electrical contact with the mounting base.



AVAILABLE OPTIONS

T_J	$V_{O(NOM)}$ (V)	PACKAGED DEVICES	
		HEAT-SINK MOUNTED (KC)	PLASTIC FLANGE MOUNTED (KTP)
0°C to 125°C	-5	μA79M05CKC	μA79M05CKTP
	-8	—	μA79M08CKTP

The KTP package also is available in tape and reel. Add the suffix R to device type (e.g., μA79M05CKTPR).



Please be aware that an important notice concerning availability, standard warranty, and use in critical applications of Texas Instruments semiconductor products and disclaimers thereto appears at the end of this data sheet.

PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

**TEXAS
INSTRUMENTS**

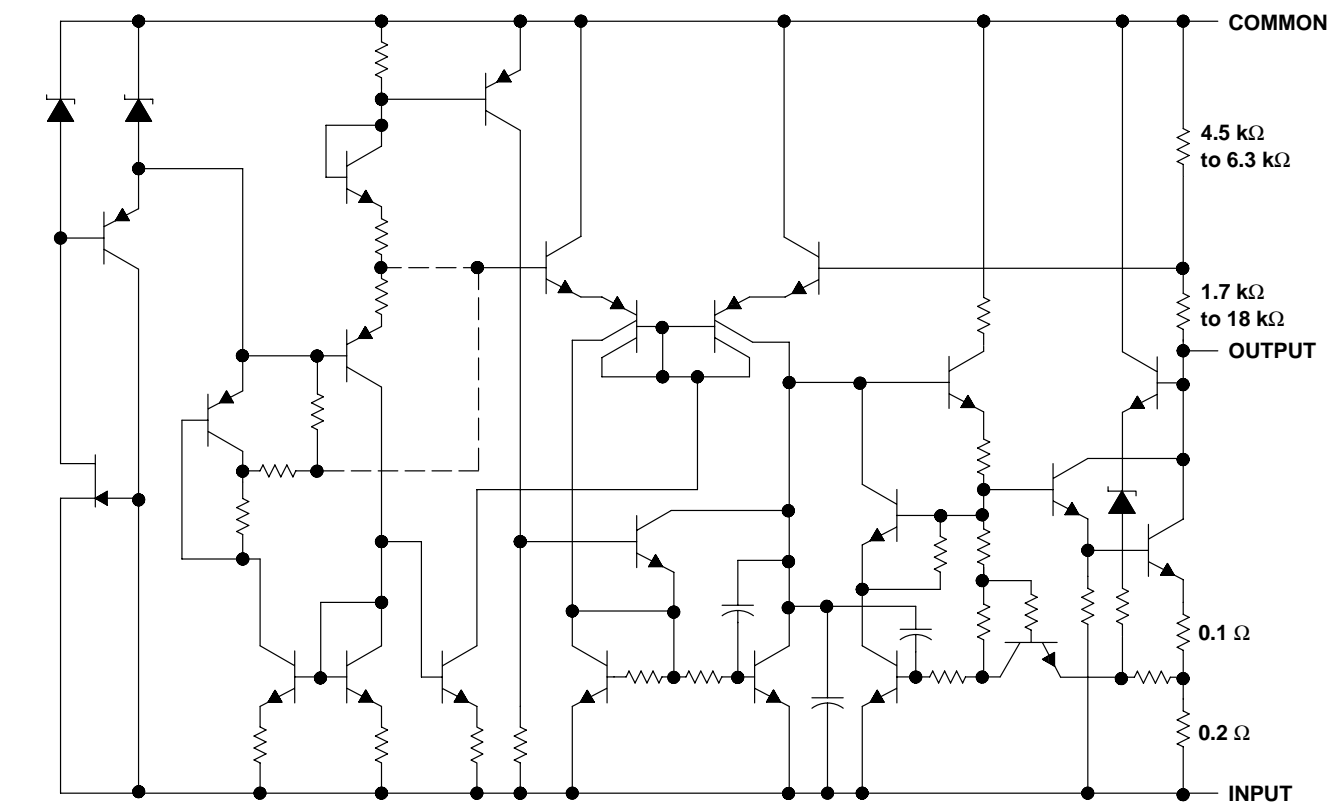
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μA79M00 SERIES
 NEGATIVE-VOLTAGE REGULATORS

SLVS060G – JUNE 1976 – REVISED OCTOBER 2001

schematic



Resistor values shown are nominal.

absolute maximum ratings over virtual junction temperature range (unless otherwise noted)[†]

Input voltage, V_I	35 V
Package thermal impedance, θ_{JA} (see Notes 1 and 2): KC package	22°C/W
(see Notes 1 and 3): KTP package	28°C/W
Lead temperature 1,6 mm (1/16 inch) from case for 10 seconds	260°C
Virtual junction temperature range, T_J	0°C to 150°C
Storage temperature range, T_{stg}	–65°C to 150°C

[†] Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

- NOTES:
- Maximum power dissipation is a function of $T_J(\text{max})$, θ_{JA} , and T_A . The maximum allowable power dissipation at any allowable ambient temperature is $P_D = (T_J(\text{max}) - T_A)/\theta_{JA}$. Selecting the maximum of 150°C can impact reliability.
 - The package thermal impedance is calculated in accordance with JESD 51-7.
 - The package thermal impedance is calculated in accordance with JESD 51-5.

recommended operating conditions

		MIN	MAX	UNIT
V_I Input voltage	μA79M05C	–7	–25	V
	μA79M08C	–10.5	–25	
I_O Output current			500	mA
T_J Operating virtual junction temperature		0	125	°C

μA79M00 SERIES NEGATIVE-VOLTAGE REGULATORS

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electrical characteristics at specified virtual junction temperature, $V_I = -10$ V, $I_O = 350$ mA, $T_J = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS†		μA79M05C			UNIT
			MIN	TYP	MAX	
Output voltage	$V_I = -7$ V to -25 V, $I_O = 5$ mA to 350 mA		-4.8	-5	-5.2	V
		$T_J = 0^\circ\text{C}$ to 125°C	-4.75		-5.25	
Input voltage regulation	$V_I = -7$ V to -25 V			7	50	mV
	$V_I = -8$ V to -18 V			3	30	
Ripple rejection	$V_I = -8$ V to -18 V, $f = 120$ Hz	$I_O = 100$ mA, $T_J = 0^\circ\text{C}$ to 125°C	50			dB
		$I_O = 300$ mA	54	60		
Output voltage regulation	$I_O = 5$ mA to 500 mA			75	100	mV
	$I_O = 5$ mA to 350 mA			50		
Temperature coefficient of output voltage	$I_O = 5$ mA, $T_J = 0^\circ\text{C}$ to 125°C			-0.4		mV/°C
Output noise voltage	$f = 10$ Hz to 100 kHz			125		μV
Dropout voltage				1.1		V
Bias current				1	2	mA
Bias current change	$V_I = -8$ V to -18 V, $T_J = 0^\circ\text{C}$ to 125°C				0.4	mA
	$I_O = 5$ mA to 350 mA, $T_J = 0^\circ\text{C}$ to 125°C				0.4	
Short-circuit output current	$V_I = -30$ V			140		mA
Peak output current				0.65		A

† Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 2-μF capacitor across the input and a 1-μF capacitor across the output.

electrical characteristics at specified virtual junction temperature, $V_I = -19$ V, $I_O = 350$ mA, $T_J = 25^\circ\text{C}$ (unless otherwise noted)

PARAMETER	TEST CONDITIONS†		μA79M08C			UNIT
			MIN	TYP	MAX	
Output voltage	$V_I = -10.5$ V to -25 V, $I_O = 5$ mA to 350 mA		-7.7	-8	-8.3	V
		$T_J = 0^\circ\text{C}$ to 125°C	-7.6		-8.4	
Input voltage regulation	$V_I = -10.5$ V to -25 V			8	80	mV
	$V_I = -11$ V to -21 V			4	50	
Ripple rejection	$V_I = -11.5$ V to -21.5 V, $f = 120$ Hz	$I_O = 100$ mA, $T_J = 0^\circ\text{C}$ to 125°C	50			dB
		$I_O = 300$ mA	54	59		
Output voltage regulation	$I_O = 5$ mA to 500 mA			90	160	mV
	$I_O = 5$ mA to 350 mA			60		
Temperature coefficient of output voltage	$I_O = 5$ mA, $T_J = 0^\circ\text{C}$ to 125°C			-0.6		mV/°C
Output noise voltage	$f = 10$ Hz to 100 kHz			200		μV
Dropout voltage	$I_O = 5$ mA			1.1		V
Bias current				1	2	mA
Bias current change	$V_I = -10.5$ V to -25 V, $T_J = 0^\circ\text{C}$ to 125°C				0.4	mA
	$I_O = 5$ mA to 350 mA, $T_J = 0^\circ\text{C}$ to 125°C				0.4	
Short-circuit output current	$V_I = -30$ V			140		mA
Peak output current				0.65		A

† Pulse-testing techniques maintain T_J as close to T_A as possible. Thermal effects must be taken into account separately. All characteristics are measured with a 2-μF capacitor across the input and a 1-μF capacitor across the output.



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